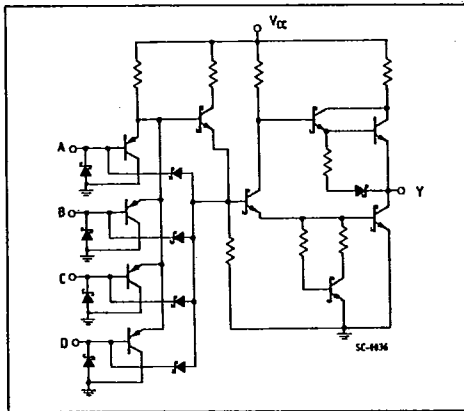


DUAL 4-INPUT NAND BUFFER

DESCRIPTION

The T74LS40 is a high speed DUAL 4-INPUT NAND BUFFER fabricated in LOW POWER SCHOTTKY technology.

SCHEMATIC



B1
(Plastic Package)

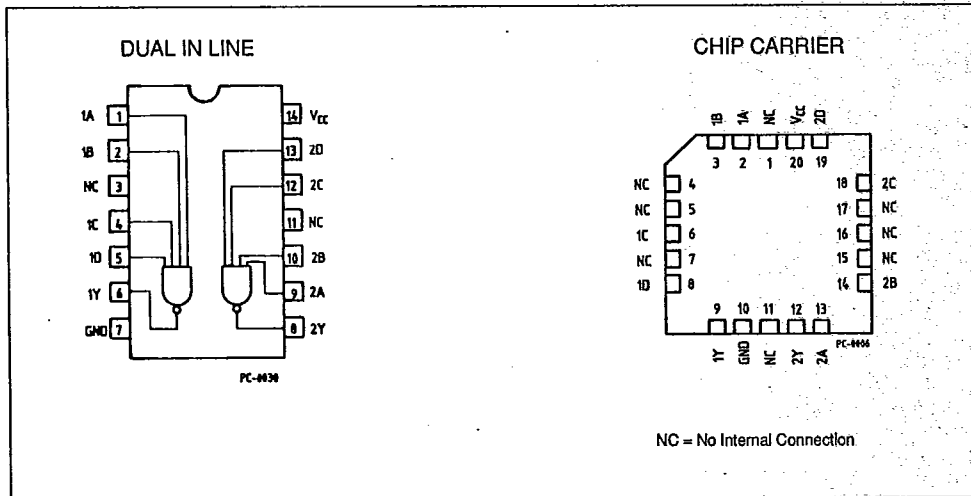
D1
(Ceramic Package)

M1
(Micro Package)

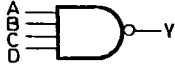
C1
(Plastic Chip Carrier)

ORDER CODES :
T74LS40 D1 T74LS40 C1
T74LS40 B1 T74LS40 M1

PIN CONNECTION (top view)



LOGIC DIAGRAM AND TRUTH TABLE



A	B	C	D	Y
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H
H	H	H	H	L

L = LOW Voltage Level
H = HIGH Voltage Level
X = Don't Care

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{CC}	Supply Voltage	- 0.5 to 7	V
V_I	Input Voltage, Applied to Input	- 0.5 to 15	V
V_O	Output Voltage, Applied to Output	- 0.5 to 10	V
I_I	Input Current, Into Inputs	- 30 to 5	mA
I_O	Output Current, Into Outputs	60	mA

Stresses in excess of those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions in excess of those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

GUARANTEED OPERATING RANGE

Part Numbers	Supply Voltage			Temperature
	Min.	Typ.	Max.	
T74LS40XX	4.75 V	5.0 V	5.25 V	0 °C to + 70 °C

XX = package type.

DC CHARACTERISTICS OVER OPERATING TEMPERATURE RANGE

Symbol	Parameter	Limits			Test Condition (note 1)	Unit
		Min.	Typ. (*)	Max.		
V_{IH}	Input HIGH Voltage	2.0			Guaranteed Input HIGH Voltage	V
V_{IL}	Input LOW Voltage			0.8	Guaranteed Input LOW Voltage	V
V_{CD}	Input Clamp Diode Voltage		- 0.65	- 1.5	$V_{CC} = \text{MIN}$, $I_{IN} = -18 \text{ mA}$	V
V_{OH}	Output HIGH Voltage	2.7	3.4		$V_{CC} = \text{MIN}$, $I_{OH} = -1.2 \text{ mA}$ $V_{IN} = V_{IL}$	V
V_{OL}	Output LOW Voltage		0.25	0.4	$I_{OL} = 12 \text{ mA}$, $V_{CC} = \text{MIN}$	V
			0.35	0.5	$I_{OL} = 24 \text{ mA}$, $V_{IN} = 2.0 \text{ V}$	V
I_{IH}	Input HIGH Current		1.0	20	$V_{CC} = \text{MAX}$, $V_{IN} = 2.7 \text{ V}$	μA
I_{IL}	Input LOW Current			0.1	$V_{CC} = \text{MAX}$, $V_{IN} = 7.0 \text{ V}$	mA
I_{IL}	Input LOW Current			- 0.4	$V_{CC} = \text{MAX}$, $V_{IN} = 0.4 \text{ V}$	mA
I_{OS}	Output Short Circuit Current (note 2)	- 30		- 130	$V_{CC} = \text{MAX}$, $V_{IN} = 0 \text{ V}$	mA
I_{CCH}	Supply Current HIGH		0.45	1.0	$V_{CC} = \text{MAX}$, $V_{IN} = 0 \text{ V}$	mA
I_{CCL}	Supply Current LOW		3.0	6.0	$V_{CC} = \text{MAX}$, Inputs Open	mA

Notes : 1. For conditions shown as MIN or MAX, use the appropriate value specified under guaranteed operating ranges.
2. Not more than one output should be shorted at a time.
(*) Typical values are at $V_{CC} = 5.0 \text{ V}$, $T_A = 25 \text{ °C}$.

AC CHARACTERISTICS: $T_A = 25^\circ\text{C}$ (for AC test circuits and waveforms see databook introduction)

Symbol	Parameter	Limits			Test Conditions	Unit
		Min.	Typ.	Max.		
t_{PLH}	Turn Off Delay, Input to Output		12	24	$V_{CC} = 5.0\text{ V}$ $C_L = 45\text{ pF}, R_L = 667\ \Omega$	ns
t_{PHL}	Turn On Delay, Input to Output		12	24		ns